

European XFEL Data-processing workshop

Wednesday 3 February 2016

Existing processing solutions - 3.11 (15:00 - 17:30)

time	[id] title	presenter
15:00	[11] X-ray detectors and diagnostics for HED instrument	Dr NAKATSUTSUMI, Motoaki
15:15	[12] Data processing requirements of the SQS instrument	Dr BAUMANN, Thomas
15:30	[13] Common approaches to data reduction in time-resolved X-ray diffuse scattering on liquids	Dr KHAKHULIN, Dmitry
15:45	[14] XPCS data analysis and requirements on the data treatment	Dr HALLMANN, Jörg
16:00	[15] Data analysis workflow for synchrotron-CDI experiments mimicking FEL Single Particle Imaging	GIEWEKEMEYER, Klaus
16:15	[16] Developments in the Single Particle Imaging Analysis Pipeline at LCLS	Dr YOON, Chun Hong
17:00	[19] Discussions	